

# STD5N52U, STF5N52U

# N-channel 525 V, 1.25 Ω typ., 4.4 A UltraFASTmesh™ Power MOSFETs in DPAK and TO-220FP packages

Datasheet - production data

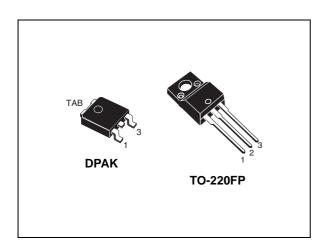
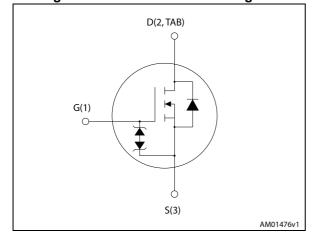


Figure 1. Internal schematic diagram



#### **Features**

Order codes	V <sub>DS</sub>	R <sub>DS(on)</sub> max	I <sub>D</sub>	P <sub>TOT</sub>
STD5N52U	525 V	1.5 Ω	4.4 A	70 W
STF5N52U	525 V	1.5 \(\Omega\)	4.4 A	25 W

- Outstanding dv/dt capability
- · Gate charge minimized
- Very low intrinsic capacitances
- Very low R<sub>DS(on)</sub>
- Extremely low t<sub>rr</sub>

### **Applications**

· Switching applications

#### **Description**

These devices are N-channel Power MOSFETs developed using UltraFASTmesh™ technology, which combines the advantages of reduced onresistance, Zener gate protection and very high dv/dt capability with an enhanced fast body-drain recovery diode.

Table 1. Device summary

Order codes	Marking	Package	Packaging
STD5N52U	5N52U	DPAK	Tape and reel
STF5N52U	3N320	TO-220FP	Tube

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STD5N52U, STF5N52U Electrical ratings

# 1 Electrical ratings

Table 2. Absolute maximum ratings

Symbol	Parameter		Value	Unit
Symbol	Farameter	DPAK	TO-220FP	
$V_{GS}$	Gate- source voltage		± 30	V
I <sub>D</sub>	Drain current (continuous) at T <sub>C</sub> = 25 °C		4.4	Α
I <sub>D</sub>	Drain current (continuous) at T <sub>C</sub> = 100 °C		2.8	Α
I <sub>DM</sub> <sup>(1)</sup>	Drain current (pulsed)		17.6	Α
P <sub>TOT</sub>	Total dissipation at T <sub>C</sub> = 25 °C	70	25	W
I <sub>AR</sub>	Avalanche current, repetitive or not-repetitive (pulse width limited by $T_J$ max)	4.4		А
E <sub>AS</sub>	Single pulse avalanche energy (starting $T_J = 25$ °C, $I_D = I_{AR}$ , $V_{DD} = 50$ V)	170		mJ
dv/dt <sup>(2)</sup>	Peak diode recovery voltage slope		20	V/ns
ESD	Gate-source human body model (R = 1.5 k $\Omega$ , C = 100 pF)	2.8		kV
V <sub>ISO</sub>	Insulation withstand voltage (RMS) from all three leads to external heat sink (t=1 s;T <sub>C</sub> =25 °C)	2500		V
TJ	Operating junction temperature	-55 to 150		°C
T <sub>stg</sub>	Storage temperature			°C

<sup>1.</sup> Pulse width limited by safe operating area.

Table 3. Thermal data

Symbol	Parameter	Va	Unit	
Symbol	r at attletel	DPAK	TO-220FP	Onne
R <sub>thj-case</sub>	Thermal resistance junction-case max	1.79	5	°C/W
R <sub>thj-amb</sub>	Thermal resistance junction-ambient max		62.5	°C/W
R <sub>thj-pcb</sub> <sup>(1)</sup>	Thermal resistance junction-pcb	50		°C/W

<sup>1.</sup> When mounted on 1 inch² FR-4 board, 2oz Cu

<sup>2.</sup>  $I_{SD} \leq 4.4 \text{ A, di/dt} \leq 400 \text{ A/}\mu\text{s, peak } V_{DS} \leq V_{(BR)DSS}$ 

# 2 Electrical characteristics

(Tcase =25 °C unless otherwise specified).

Table 4. On /off states

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V <sub>(BR)DSS</sub>	Drain-source breakdown voltage (V <sub>GS</sub> = 0)	I <sub>D</sub> = 1 mA	525			V
1	$I_{DSS}$ Zero gate voltage drain current ( $V_{GS} = 0$ ) $I_{GSS}$ Gate-body leakage current ( $V_{DS} = 0$ )	V <sub>DS</sub> = 525 V			10	μΑ
DSS		V <sub>DS</sub> = 525 V, T <sub>C</sub> =125 °C			500	μΑ
I <sub>GSS</sub>		V <sub>GS</sub> = 20 V			±10	μΑ
V <sub>GS(th)</sub>	Gate threshold voltage	$V_{DS} = V_{GS}$ , $I_D = 50 \mu A$	3	3.75	4.5	V
R <sub>DS(on)</sub>	Static drain-source on- resistance	$V_{GS} = 10 \text{ V}, I_D = 2.2 \text{ A}$		1.25	1.5	Ω

Table 5. Dynamic

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
C <sub>iss</sub>	Input capacitance		-	529	-	рF
C <sub>oss</sub>	Output capacitance	$V_{DS} = 25 \text{ V, f} = 1 \text{ MHz,}$	-	71	-	pF
C <sub>rss</sub>	Reverse transfer capacitance	V <sub>GS</sub> = 0	-	13.4	-	pF
C <sub>o(tr)</sub> <sup>(1)</sup>	Equivalent capacitance time related	V <sub>DS</sub> = 0 to 420 V, V <sub>GS</sub> = 0	-	11	1	pF
R <sub>g</sub>	Gate input resistance	f=1 MHz open drain	-	6	ı	Ω
$Q_g$	Total gate charge	V <sub>DD</sub> = 416 V, I <sub>D</sub> = 4.4 A,	-	16.9	ı	nC
Q <sub>gs</sub>	Gate-source charge	V <sub>GS</sub> = 10 V	-	4.2	-	nC
Q <sub>gd</sub>	Gate-drain charge	(see Figure 17)	-	8.4	-	nC

<sup>1.</sup>  $C_{oss\,eq}$  time related is defined as a constant equivalent capacitance giving the same charging time as  $C_{oss}$  when  $V_{DS}$  increases from 0 to 80%  $V_{DSS}$ 

Table 6. Switching times

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
t <sub>d(on)</sub>	Turn-on delay time		-	11.4	-	ns
t <sub>r</sub>	Rise time	$V_{DD} = 260 \text{ V}, I_{D} = 2.2 \text{ A},$ $R_{G} = 4.7 \Omega, V_{GS} = 10 \text{ V}$ (see Figure 16)	-	13.6	-	ns
t <sub>d(off)</sub>	Turn-off-delay time		-	23.1	-	ns
t <sub>f</sub>	Fall time		-	15	-	ns

Table 7. Source drain diode

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
I <sub>SD</sub>	Source-drain current		-		4.4	Α
I <sub>SDM</sub> <sup>(1)</sup>	Source-drain current (pulsed)		-		17.6	Α
V <sub>SD</sub> <sup>(2)</sup>	Forward on voltage	$I_{SD} = 4.4 \text{ A}, V_{GS} = 0$	-		1.6	V
t <sub>rr</sub>	Reverse recovery time	I <sub>SD</sub> = 4.4 A, di/dt = 100 A/μs	-	55		ns
Q <sub>rr</sub>	Reverse recovery charge	V <sub>DD</sub> = 60 V (see Figure 18)	-	95		nC
I <sub>RRM</sub>	Reverse recovery current		-	3.5		Α
t <sub>rr</sub>	Reverse recovery time	I <sub>SD</sub> = 4.4 A, di/dt = 100 A/μs	-	120		ns
Q <sub>rr</sub>	Reverse recovery charge	V <sub>DD</sub> = 60 V T <sub>J</sub> = 150 °C	-	266		nC
I <sub>RRM</sub>	Reverse recovery current	(see Figure 18)	-	4.5		Α

<sup>1.</sup> Pulse width limited by safe operating area

Table 8. Gate-source Zener diode

Symbol	Parameter	Test conditions	Min	Тур.	Max.	Unit
V <sub>(BR)GSO</sub>	Gate-source breakdown voltage	$I_{GS} = \pm 1 \text{mA}, I_D = 0$	30	-	-	V

The built-in back-to-back Zener diodes have specifically been designed to enhance the device's ESD capability. In this respect the Zener voltage is appropriate to achieve an efficient and cost-effective intervention to protect the device's integrity. These integrated Zener diodes thus avoid the usage of external components.

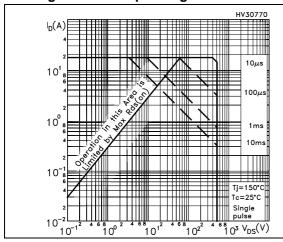


<sup>2.</sup> Pulsed: pulse duration = 300  $\mu$ s, duty cycle 1.5%

### 2.1 Electrical characteristics (curves)

Figure 2. Safe operating area for DPAK

Figure 3. Thermal impedance for DPAK



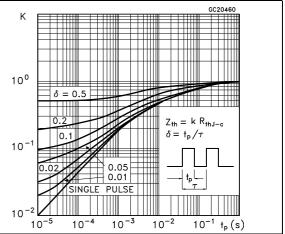
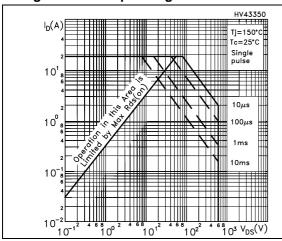


Figure 4. Safe operating area for TO-220FP

Figure 5. Thermal impedance for TO-220FP



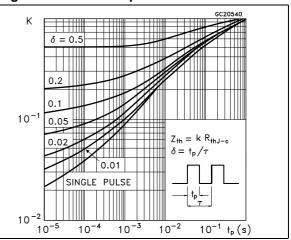
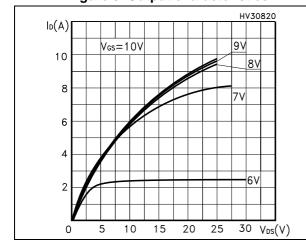


Figure 6. Output characteristics

Figure 7. Transfer characteristics



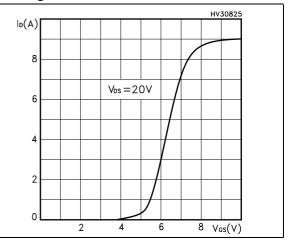
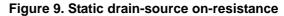
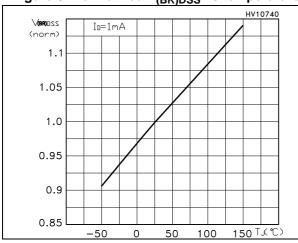


Figure 8. Normalized  $V_{(BR)DSS}$  vs temperature





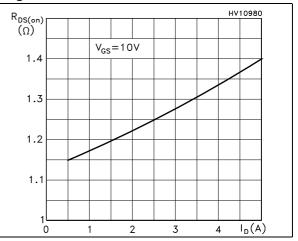
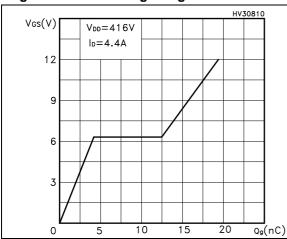


Figure 10. Gate charge vs gate-source voltage

Figure 11. Capacitance variations



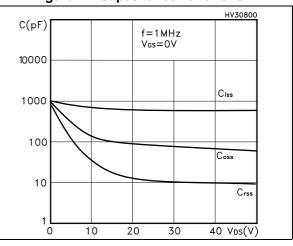
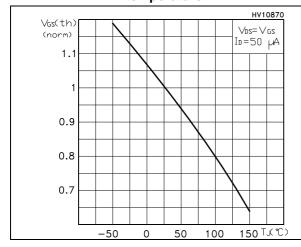
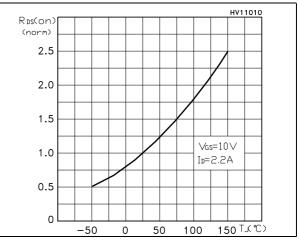


Figure 12. Normalized gate threshold voltage vs temperature

Figure 13. Normalized on-resistance vs temperature

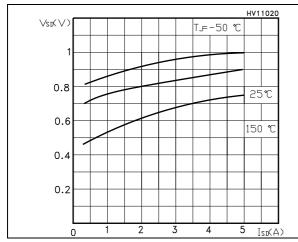


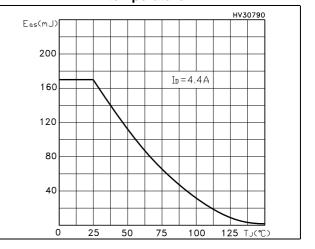


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Figure 14. Source-drain diode forward characteristics

Figure 15. Maximum avalanche energy vs temperature





STD5N52U, STF5N52U Test circuits

## 3 Test circuits

Figure 16. Switching times test circuit for resistive load

Figure 17. Gate charge test circuit

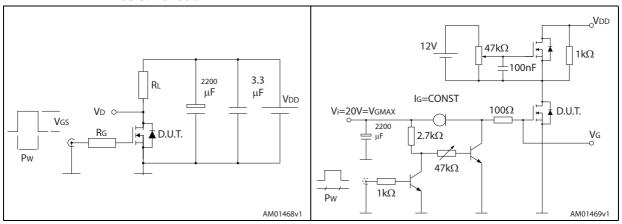


Figure 18. Test circuit for inductive load switching and diode recovery times

Figure 19. Unclamped inductive load test circuit

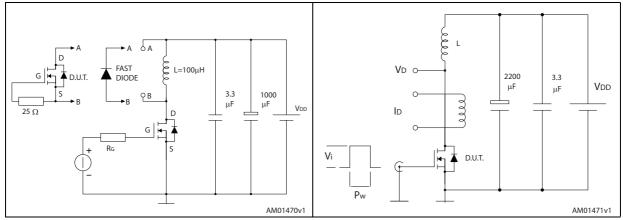
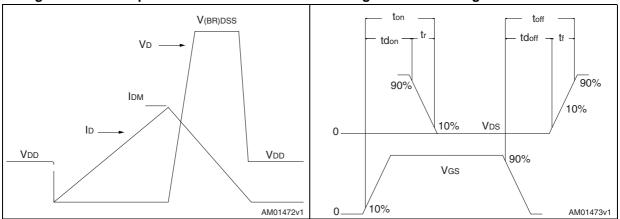


Figure 20. Unclamped inductive waveform

Figure 21. Switching time waveform





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# 4 Package mechanical data

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK<sup>®</sup> packages, depending on their level of environmental compliance. ECOPACK<sup>®</sup> specifications, grade definitions and product status are available at: <a href="https://www.st.com">www.st.com</a>. ECOPACK<sup>®</sup> is an ST trademark.

# 4.1 DPAK, STD5N52U

Ε THERMAL PAD c2 E1 L2 D Note 7 <u>b(</u>2x) R С SEATING PLANE (L1) *V2* 0,25 0068772\_N

Figure 22. DPAK (TO-252) type A drawing

Table 9. DPAK (TO-252) type A mechanical data

Dim		mm	
Dim.	Min.	Тур.	Max.
Α	2.20		2.40
A1	0.90		1.10
A2	0.03		0.23
b	0.64		0.90
b4	5.20		5.40
С	0.45		0.60
c2	0.48		0.60
D	6.00		6.20
D1		5.10	
Е	6.40		6.60
E1		4.70	
е		2.28	
e1	4.40		4.60
Н	9.35		10.10
L	1.00		1.50
(L1)		2.80	
L2		0.80	
L4	0.60		1.00
R		0.20	
V2	0°		8°

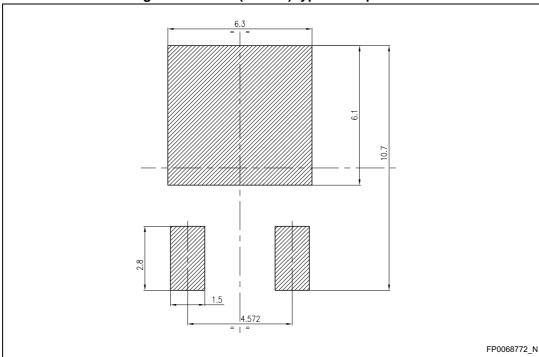


Figure 23. DPAK (TO-252) type A footprint <sup>(a)</sup>

a. All dimensions are in millimeters



# 4.2 TO-220FP, STF5N52U

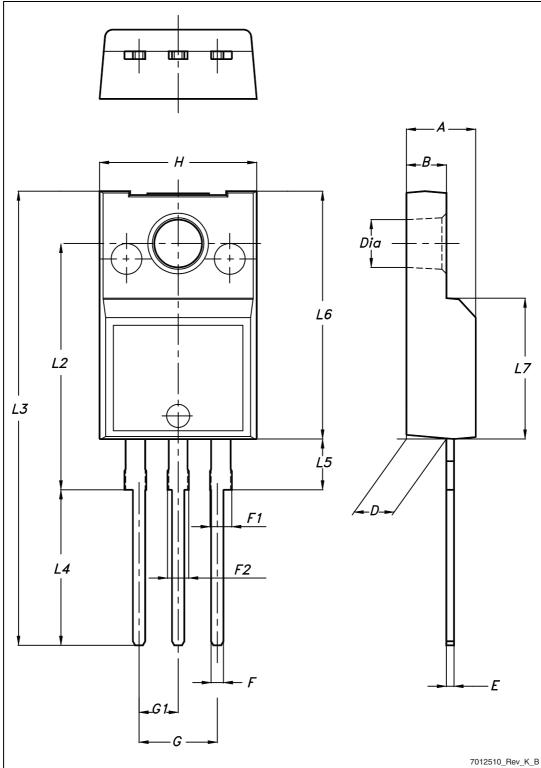


Figure 24. TO-220FP drawing

Table 10. TO-220FP mechanical data

		mm	
Dim.	Min.	Тур.	Max.
А	4.4		4.6
В	2.5		2.7
D	2.5		2.75
E	0.45		0.7
F	0.75		1
F1	1.15		1.70
F2	1.15		1.70
G	4.95		5.2
G1	2.4		2.7
Н	10		10.4
L2		16	
L3	28.6		30.6
L4	9.8		10.6
L5	2.9		3.6
L6	15.9		16.4
L7	9		9.3
Ø	3		3.2



# 5 Packaging mechanical data

Figure 25. Tape for DPAK (TO-252)

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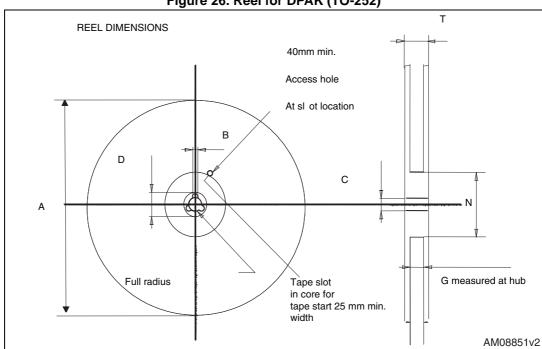


Figure 26. Reel for DPAK (TO-252)

Table 11. DPAK (TO-252) tape and reel mechanical data

	Таре	, ,		Reel		
Dim.	mm		Dim.	mm		
	Min.	Max.		Min.	Max.	
A0	6.8	7	Α		330	
В0	10.4	10.6	В	1.5		
B1		12.1	С	12.8	13.2	
D	1.5	1.6	D	20.2		
D1	1.5		G	16.4	18.4	
Е	1.65	1.85	N	50		
F	7.4	7.6	Т		22.4	
K0	2.55	2.75				
P0	3.9	4.1		Base qty.	2500	
P1	7.9	8.1		Bulk qty.	2500	
P2	1.9	2.1				
R	40					
T	0.25	0.35				
W	15.7	16.3				



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# 6 Revision history

Table 12. Document revision history

Date	Revision	Changes	
06-May-2009	1	First release.	
28-Sep-2011 2		<ul> <li>Inserted new device in I<sup>2</sup>PAK.</li> <li>Updated tables 1, 2 and 3 with the new package.</li> <li>Updated Section 4: Package mechanical data with the new package and Section 5: Packaging mechanical data.</li> <li>Minor text changes.</li> </ul>	
- Modified: Q <sub>rr</sub> unit in <i>Table 7</i> 24-Apr-2014 3 - Modified: <i>Figure 8</i> and <i>11</i>		<ul> <li>Modified: Figure 8 and 11</li> <li>The part number STI5N52U has been moved to a separate</li> </ul>	

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